

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L11	21	("4415227" "4582390" "4592043" "4737007" "4786132" "4955028" "5042898" "5134620" "5317576" "5418802" "5459801" "5504772" "5577141" "5581642" "5672672" "5732102" "5857039" "5870417" "5875272" "6052495" "6243517"). PN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/02/27 16:05
L10	174	(waveguide or waveguiding or wave-guide) same (test or testing or tested) same (cleav\$4 or singulat\$4 or dicing or diced or scrib\$4 or (chip or die or ic) near (separation or separating or separated or cut or cutting))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/27 15:50
L9	186	(test or testing or tested) near3 (between or partially or partial or during or while or in-process) near3 (cleav\$4 or singulat\$4 or dicing or diced or scrib\$4 or (chip or die or ic) near (separation or separating or separated or cut or cutting))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/27 15:49
L8	636	(test or testing or tested or inspection or inspecting) near5 (between or partially or partial or during or while or in-process) near8 (cleav\$4 or singulat\$4 or dicing or diced or scrib\$4 or (chip or die or ic) near2 (separation or separating or separated or cut or cutting))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/27 15:37
L7	41	(awg or arrayed near waveguide near grating or waveguide near router or wavelength near router or (wavelength or waveguide or optical) near3 (multiplex\$4)) same (test or testing or tested) same (singulat\$4 or cleav\$4 or dicing or diced or scrib\$4)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/27 15:35
L5	52	(awg or arrayed near waveguide near grating or waveguide near router or wavelength near router) near8 (test or testing or tested) and (wavelength or lambda or frequency) and (waveguide or guiding or waveguiding)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/27 15:11
L6	16	L5 not L4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/27 14:54

EAST Search History

L3	205	(awg or arrayed near waveguide near grating or waveguide near router or wavelength near router) near8 (test or testing or tested)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/27 14:53
L4	48	(awg or arrayed near waveguide near grating or waveguide near router or wavelength near router) near8 (test or testing or tested) same (singulat\$4 or cleav\$4 or diced or dicing or scrib\$4 or cutting or cut or separation or separated)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/27 14:47
S28	2	"5926586".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/27 14:38
S11 6	160	(awg or waveguide or multiplex\$3 or demultiplex\$3) near10 (test or testing or tested or inspected or inspection or inspecting) near10 (strip or matrix or cleaved or cleaving or scribed or scribing or singulation or singulated or diced or dicing)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/17 13:48
S11 4	1551	(awg or waveguide or multiplex\$3 or demultiplex\$3) near10 (test or testing or tested or inspected or inspection or inspecting) near10 (line or strip or matrix or cleaved or cleaving or scribed or scribing or singulation or singulated or diced or dicing)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/17 12:41
S11 3	11128	(awg or waveguide or multiplex\$3 or demultiplex\$3) near10 (test or testing)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/17 12:39
S1	20	"6529670".pn. "6528864".pn. "6513564".pn. "6021267".pn. "5777386".pn. "5661316".pn. "5341024".pn. "5327517".pn. "5223741".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/17 12:38
S11 2	2	"5309001".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/31 17:24
S11 1	39	(awg or waveguide or wdm or multiplex\$4) near10 (testing or tested or test) near3 (wafer near scale or wafer near level or (chip or die or element) near2 (strip or line))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/31 17:18

EAST Search History

S10 8	727	(awg or waveguide or wdm or multiplex\$4) near5 (testing or tested or test) near5 ((before or prior or earlier or preceding or preceeding) near2 (cleav\$4 or dicing or diced or singulation or singulated or singulating or scribing or scribed or separation or separated or separating or cutting or cut) or (strip or line or wafer near scale or wafer near level))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/31 16:23
S11 0	17	(awg or waveguide or wdm or multiplex\$4) near15 (testing or tested or test) near15 ((before or prior or earlier or preceding or preceeding) near2 (cleav\$4 or dicing or diced or singulation or singulated or singulating or scribing or scribed or separation or separated or separating or cutting or cut))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/31 16:18
S10 4	593	(awg or waveguide or laser) near5 (testing or tested or test) near10 ((before or prior or earlier or preceding or preceeding) near2 (cleav\$4 or dicing or diced or singulation or singulated or singulating or scribing or scribed or separation or separated or separating or cutting or cut) or (strip or line or wafer near scale or wafer near level))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/31 16:13
S10 7	3	"6707133".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/31 16:07
S10 6	42	(awg or arrayed near waveguide or wdm or wavelength near2 multiplex\$3) near10 (test or testing or tested) same (cleaving or cleaved or singulation or singulated or singulating or dicing or diced or separating or separation or scribing or scribed)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/31 16:07
S10 5	628	(awg or arrayed near waveguide or wdm or wavelength near2 multiplex\$3) near10 (test or testing or tested)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/31 16:05

EAST Search History

S10 3	1673	(awg or waveguide or optical or light near emitting) near5 (testing or tested or test) near10 ((before or prior or earlier or preceding or preceeding) near2 (cleav\$4 or dicing or diced or singulation or singulated or singulating or scribing or scribed or separation or separated or separating or cutting or cut) or (strip or line or wafer near scale or wafer near level))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/31 15:51
S10 2	73	(awg or waveguide or laser) near8 (cleav\$4 or dicing or diced or singulation or singulated or singulating or scribing or scribed or separation or separated or separating or cutting or cut) near6 (strip or line) near10 (test or testing or tested)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/31 15:48